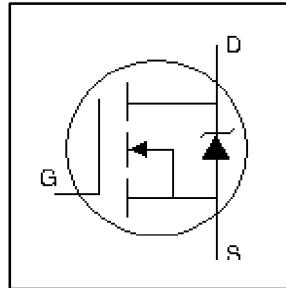


## **HEXFET® Power MOSFET**

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Fast Switching
- Ease of paralleling
- Simple Drive Requirements

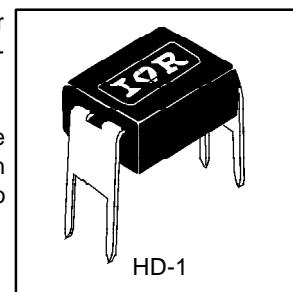


$V_{DSS} = 600V$
$R_{DS(on)} = 4.4\Omega$
$I_D = 0.32A$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4-pin DIP package is a low-cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1 inch pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 watt.



### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	0.32	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	0.20	
$I_{DM}$	Pulsed Drain Current ①	2.6	W
$P_D @ T_C = 25^\circ C$	Power Dissipation	1.0	
	Linear Derating Factor	0.0083	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	50	mJ
$I_{AR}$	Avalanche Current ①	0.32	A
$E_{AR}$	Repetitive Avalanche Energy ①	0.10	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	3.0	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	$^\circ C$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

### Thermal Resistance

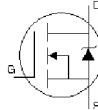
	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient	—	—	120	$^\circ C/W$

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	600	—	—	V
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.88	—	V/ $^\circ\text{C}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	4.4	$\Omega$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V
$g_{\text{fs}}$	Forward Transconductance	1.4	—	—	S
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$
		—	—	250	
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$
	Gate-to-Source Reverse Leakage	—	—	-100	
$Q_g$	Total Gate Charge	—	—	18	$\text{nC}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	3.0	
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	—	8.9	
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	10	—	$\text{ns}$
$t_r$	Rise Time	—	23	—	
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	30	—	
$t_f$	Fall Time	—	25	—	
$L_D$	Internal Drain Inductance	—	4.0	—	$\text{nH}$
$L_S$	Internal Source Inductance	—	6.0	—	
$C_{\text{iss}}$	Input Capacitance	—	350	—	
$C_{\text{oss}}$	Output Capacitance	—	48	—	$\text{pF}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	8.6	—	
					Between lead, 6mm (0.25in.) from package and center of die contact

**Source-Drain Ratings and Characteristics**

Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	0.32	MOSFET symbol showing the integral reverse p-n junction diode.
		—	—	2.6	
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	V	$T_J = 25^\circ\text{C}, I_S = 0.32\text{A}, V_{\text{GS}} = 0\text{V}$ ④
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.6	$T_J = 25^\circ\text{C}, I_F = 2.0\text{A}$
$t_{\text{rr}}$	Reverse Recovery Time	—	290	580	$T_J = 25^\circ\text{C}, I_F = 2.0\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	0.67	1.3	$\mu\text{C}$ $dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )			

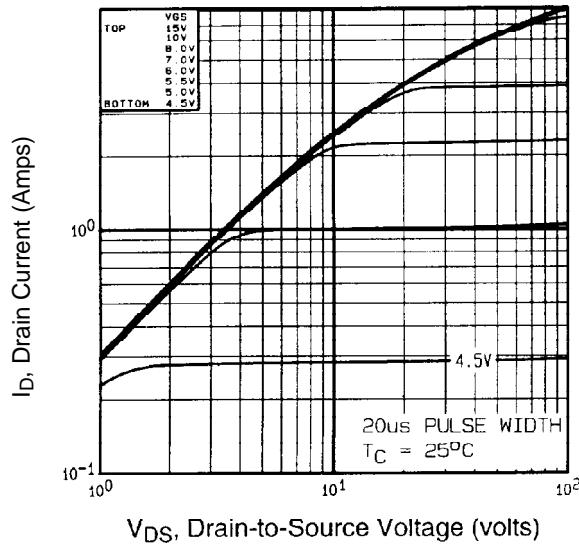
**Notes:**

① Repetitive rating; pulse width limited by max. junction temperature.

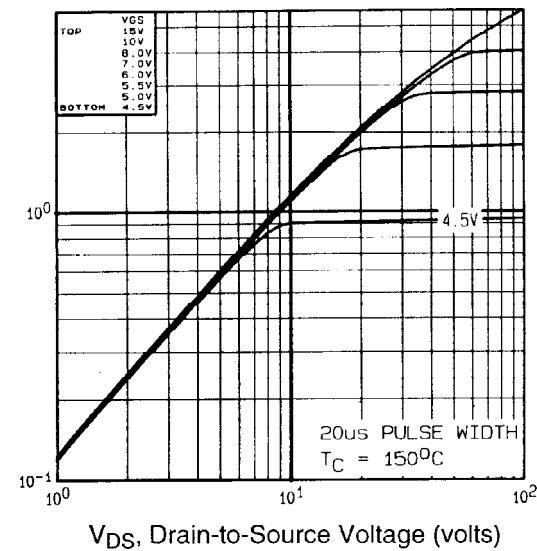
③  $I_{\text{SD}} \leq 4.4\text{A}$ ,  $di/dt \leq 90\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$

②  $V_{\text{DD}} = 50\text{V}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 54\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{\text{AS}} = 1.3\text{A}$ .

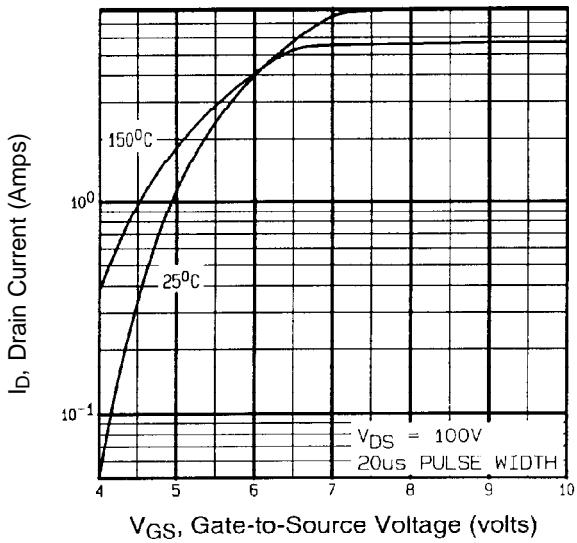
④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .



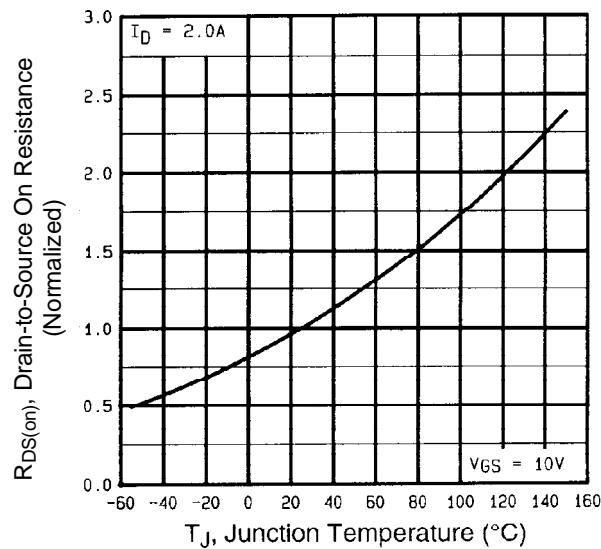
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$

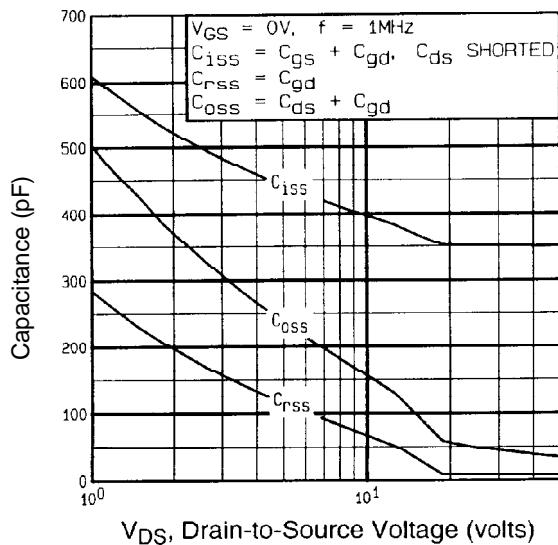


**Fig 3.** Typical Transfer Characteristics

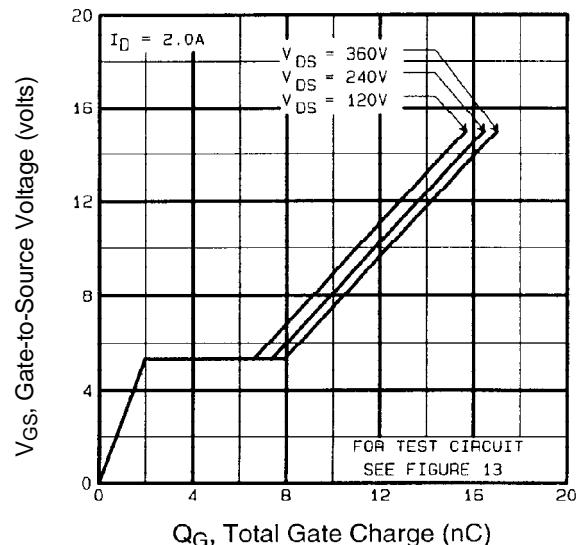


**Fig 4.** Normalized On-Resistance  
Vs. Temperature

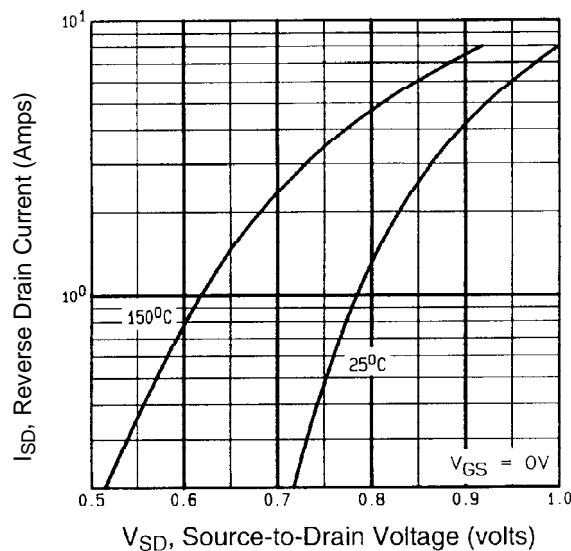
# IRFDC20



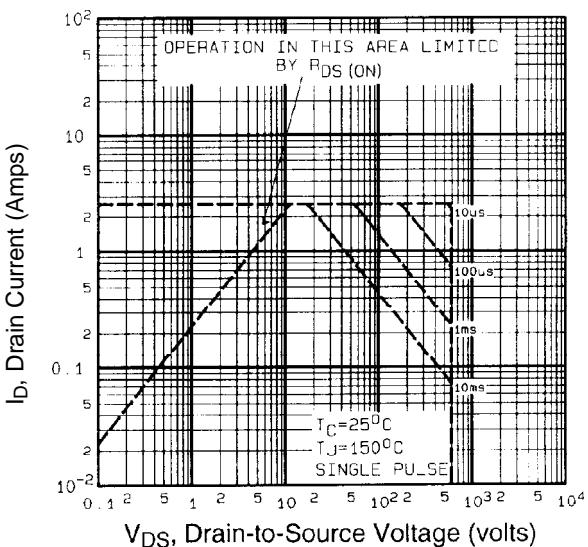
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



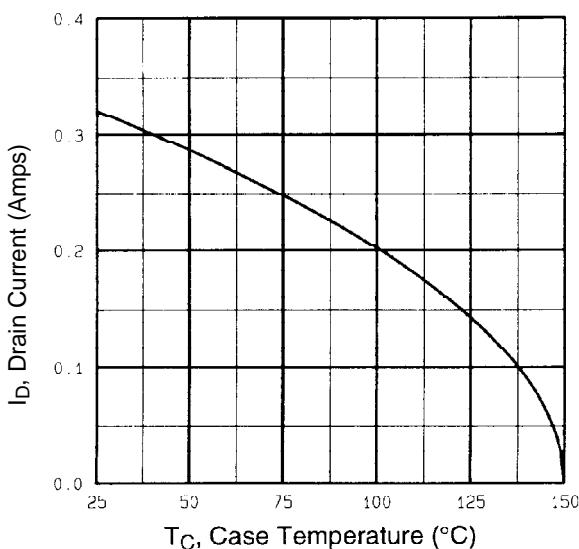
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



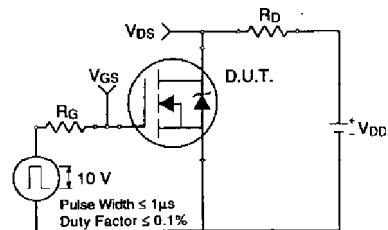
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



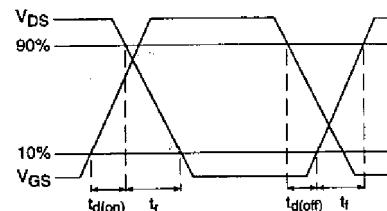
**Fig 8.** Maximum Safe Operating Area



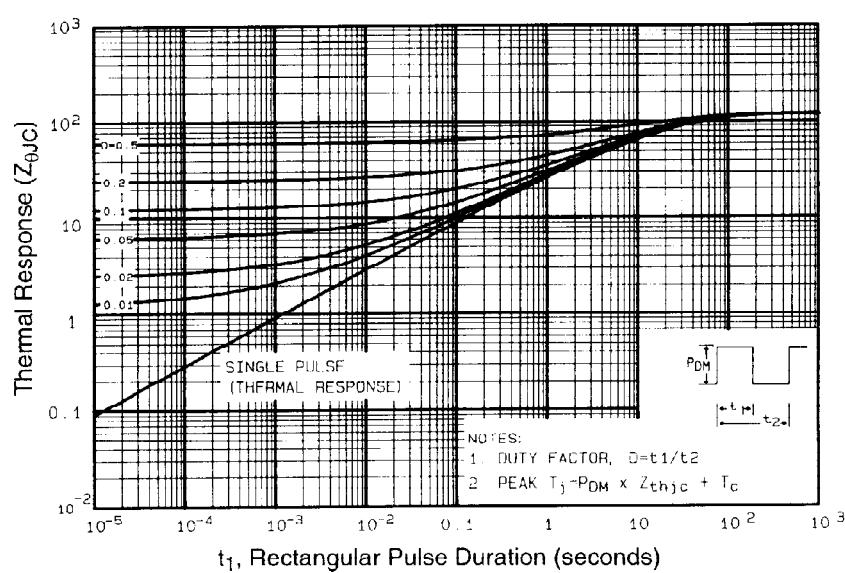
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFDC20

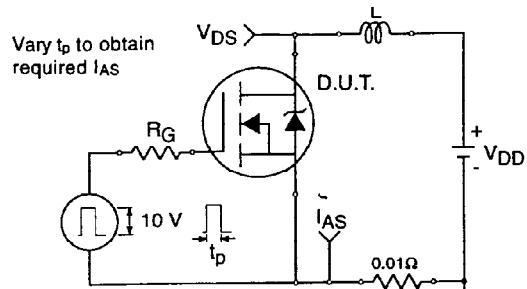


Fig 12a. Unclamped Inductive Test Circuit

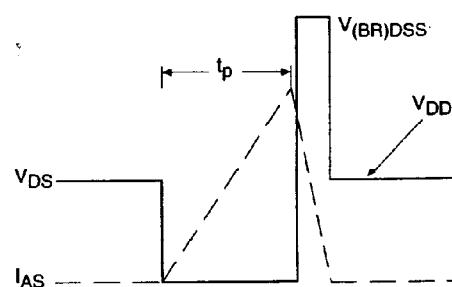


Fig 12b. Unclamped Inductive Waveforms

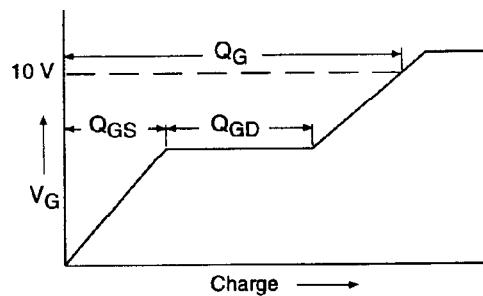


Fig 13a. Basic Gate Charge Waveform

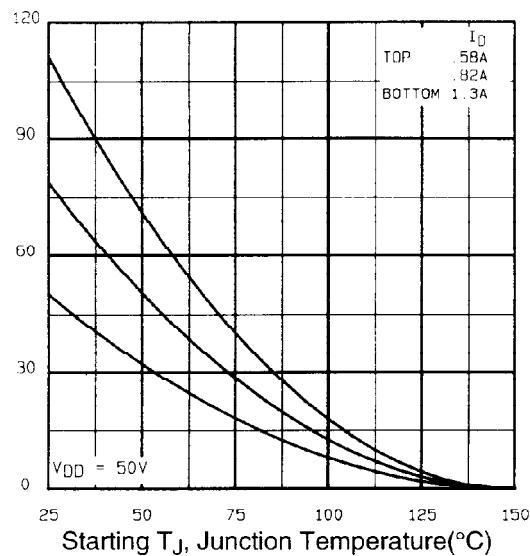


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

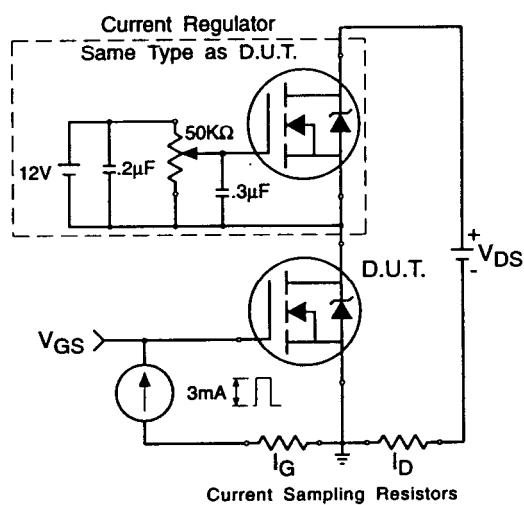
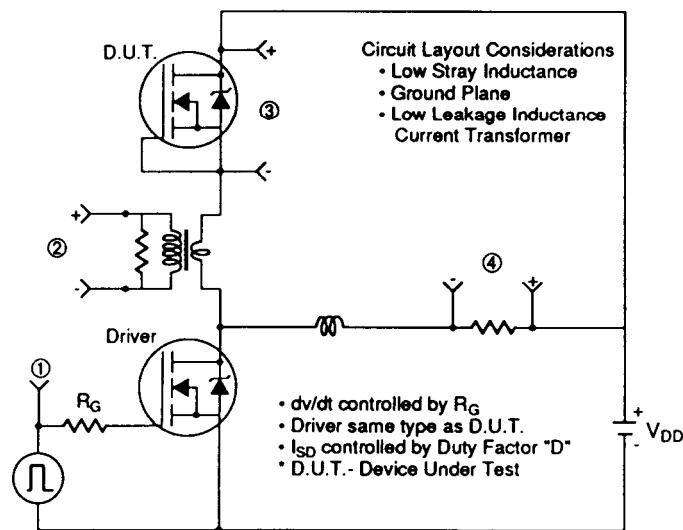


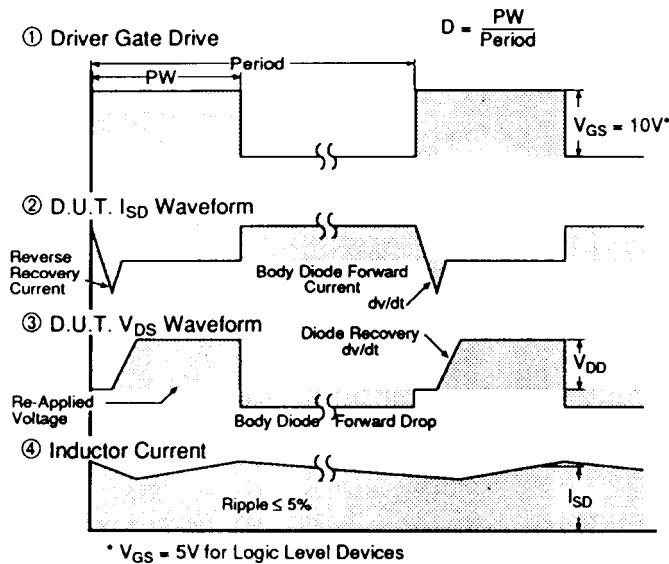
Fig 13b. Gate Charge Test Circuit

## dv/dt Test Circuit

Fig 14. For N-Channel HEXFETs



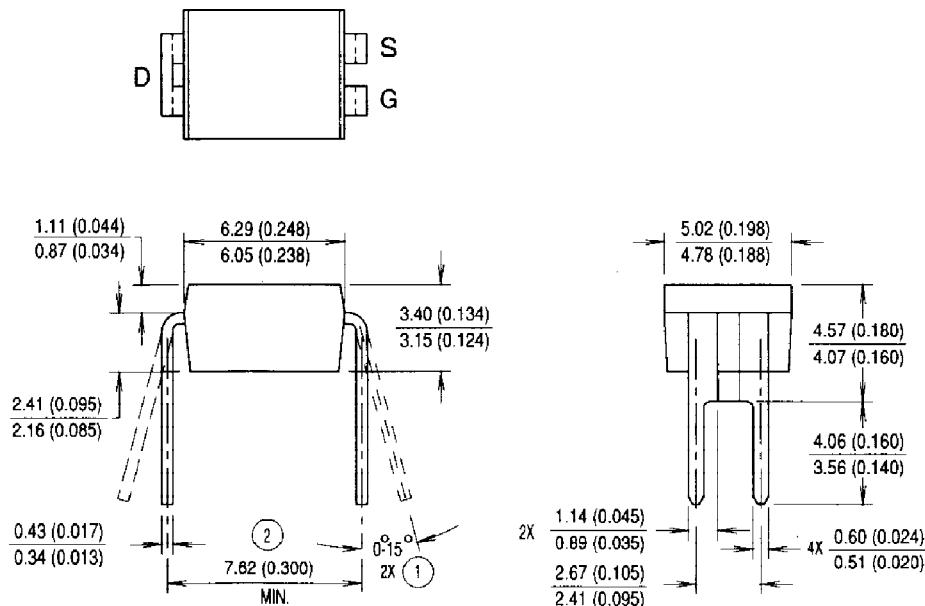
## Peak Diode Recovery Test Circuit



# IRFDC20



## Package Outline



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**IR** Rectifier

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**IR CANADA:** 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 3L1, Tel: (905) 475 1897 **IR GERMANY:**

Saalburgstrasse 157, 61350 Bad Homburg Tel: 6172 37066 **IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: (39)

1145 10111 **IR FAR EAST:** K&H Bldg., 2F, 3-30-4 Nishi-Ikeburo 3-Chome, Toshima-Ki, Tokyo 171 Tel: (03)3983 0641

**IR SOUTHEAST ASIA:** 315 Outram Road, #10-02 Tan Boon Liat Building, 0316 Tel: 65 221 8371

*Data and specifications subject to change without notice.*